

Notice of References Cited	Application/Control No. 10/594,007		Applicant(s)/Patent Under Reexamination FUKUOKA, SHINYA	
	Examiner ZHIYU LU		Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,646,555	11-2003	Forster et al.	340/572.8
*	B	US-2004/0259499	12-2004	Oba et al.	455/041.2
*	C	US-2002/0033757	03-2002	Rodgers et al.	340/572.1
*	D	US-4,857,851	08-1989	Anderson et al.	324/326
*	E	US-2004/0155782	08-2004	Letkomiller et al.	340/573.3
*	F	US-2006/0007003	01-2006	Yamagiwa, Toshio	340/572.1
*	G	US-2004/0056778	03-2004	Hilliard, Steven R.	340/933
*	H	US-7,135,975	11-2006	Hoshina et al.	340/572.1
*	I	US-6,322,415	11-2001	Cyrus et al.	446/130
*	J	US-2004/0260455	12-2004	Dort, David Bogart	701/117
*	K	US-2002/0146978	10-2002	Basson et al.	455/11.1
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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